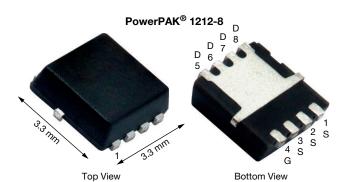
Vishay Siliconix

N-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	30			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.0192			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0245			
Q _g typ. (nC)	4.7			
I _D (A) a, g	6			
Configuration	Single			

FEATURES

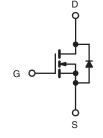
- TrenchFET® Gen III power MOSFET
- 100 % R_g tested and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS COMPLIANT HALOGEN FREE

APPLICATIONS

- DC/DC conversion
 - System power



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 1212-8
Lead (Pb)-free and halogen-free	Si7804BDN-T1-GE3

ABSOLUTE MAXIMUM RATING	13 (1A = 25 C, 1	inless otherwis	se notea)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	30	V	
Gate-source voltage		V _{GS}	+20 / -16	v	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		6 ^{a, g}		
	T _C = 70 °C	1 . 🗆	6 ^g		
	T _A = 25 °C		6 ^{b, c}	^	
	T _A = 70 °C	7 -	6 b, c	A	
Pulsed drain current		I _{DM}	24		
Avalanche current	. 0.1 11	I _{AS}	10		
Avalanche energy	L = 0.1 mH	E _{AS}	5	mJ	
Continuous source-drain diode current	T _C = 25 °C		6 ^{a, g}	Δ.	
	T _A = 25 °C	ls	2.7 ^{b, c}	A	
Maximum power dissipation	T _C = 25 °C		19.9		
	T _C = 70 °C	1 , [12.7	w	
	T _A = 25 °C	P _D	3.2 ^{b, c}	VV	
	T _A = 70 °C	7	2.1 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	31	39	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	5	6.3	C/VV	

- Based on T_C = 25 °C
- Surface mounted on 1" x 1" FR4 board
- t = 10 s
- See solder profile (www.vishav.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 81 °C/W
- Package limited

Vishay Siliconix

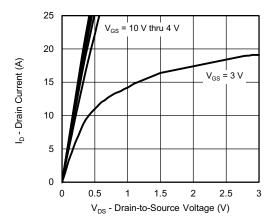
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	14.3	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$	-	-4.7	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \ \mu A$	1.2	-	2.2	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{V} / -16 \text{ V}$	-	-	± 100	nA	
7	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	μА	
Zero gate voltage drain current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	5	-	-	Α	
Drain-source on-state resistance ^a	В	V _{GS} = 10 V, I _D = 5 A	-	0.0155	0.0192		
	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 4 A	-	0.0190	0.0245	Ω	
Forward transconductance a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	22	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	765	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	225	-		
Reverse transfer capacitance	C _{rss}		-	14	-		
Tatalantanham	Q _g	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 5 A	-	10	15	nC	
Total gate charge		* *	-	4.7	7.1		
Gate-source charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	2.2	-		
Gate-drain charge	Q _{qd}		-	0.65	-		
Gate resistance	R_{g}	f = 1 MHz	1.3	6.3	12.6	Ω	
Turn-on delay time	t _{d(on)}		-	6	15		
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega,$	-	25	50		
Turn-off delay time	t _{d(off)}	$I_D \cong 5$ A, $V_{GEN} = 10$ V, $R_g = 1~\Omega$	-	15	30		
Fall time	t _f		-	10	20		
Turn-on delay time	t _{d(on)}		-	17	35	ns	
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega,$	-	45	90		
Turn-off delay time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	16	30		
Fall time	t _f		-	27	50		
Drain-Source Body Diode Characteristi	cs				•		
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	6		
Pulse diode forward current	I _{SM}		-	-	24	Α	
Body diode voltage	V _{SD}	$I_S = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.81	1.2	V	
Body diode reverse recovery time	t _{rr}		_	21	40	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	10	20	nC	
Reverse recovery fall time	t _a	$T_J = 25 ^{\circ}\text{C}$	-	12	-		
Reverse recovery rise time	t _b		_	9	_	ns	

Notes

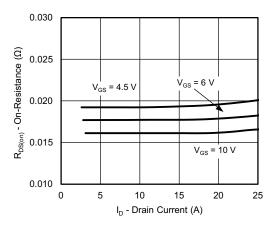
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

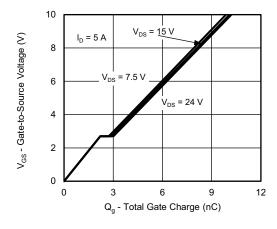




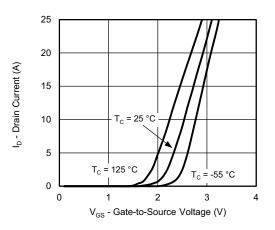
Output Characteristics



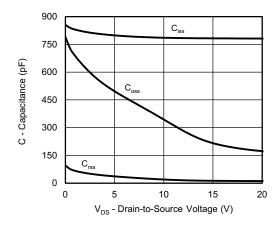
On-Resistance vs. Drain Current and Gate Voltage



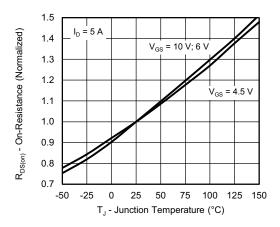
Gate Charge



Transfer Characteristics

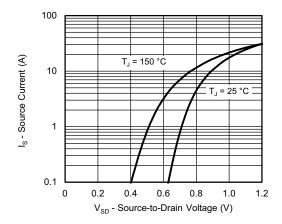


Capacitance

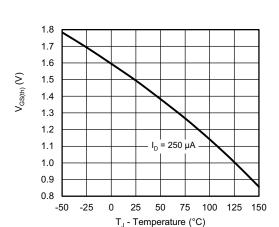


On-Resistance vs. Junction Temperature

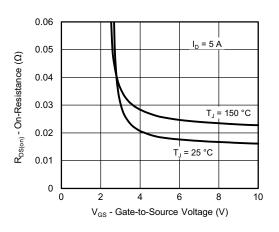




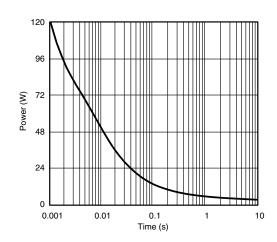
Source-Drain Diode Forward Voltage



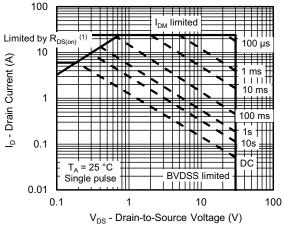
Threshold Voltage



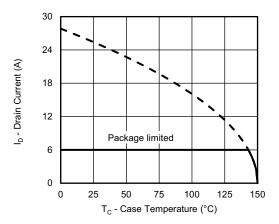
On-Resistance vs. Gate-to-Source Voltage



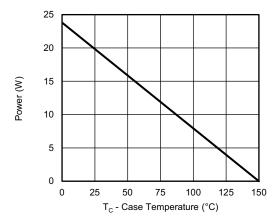
Single Pulse Power (Junction-to-Ambient)

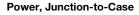


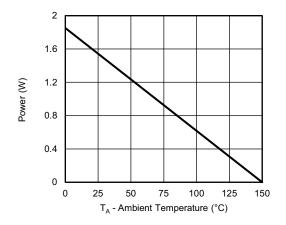




Current Derating a





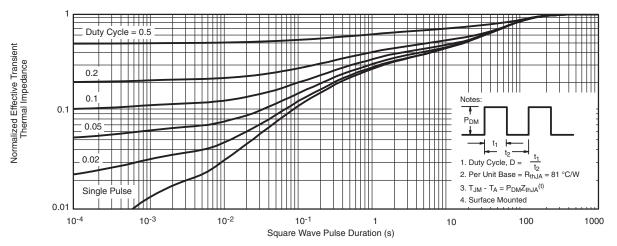


Power, Junction-to-Ambient

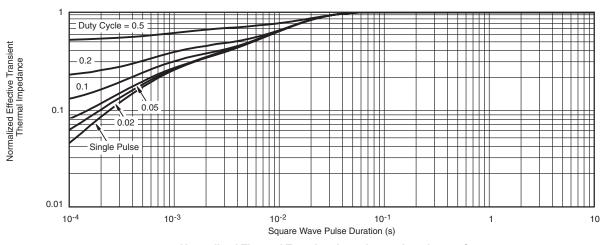
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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